Random bad cell map for wafer 177 s/n: Y21316-09-06

Date: 07/08/99

		5	0	0	0			
			0	0	0			
	0	0	0		0	0	0	
	15	1	0	5	1	0	0	
0	0	6	0		2	0	8	0
	0	0	75	20	23	0	0	0
	0	1	16	19	32	1	0	0
0	0	11	15	7	17	2	0	1
		12	6	2	8	3	0	
		12	5		11	5	0	
0	0	5	8	7	6		0	
	0		6		2	0	0	0
0	0	0	3	3	0	0	0	0
0	0	0	0	0	0	0		0
	0	0	0	0	0	54	0	
	0	0		0	0		23	
		1		0		0		
				0		0		

#	Number of bad cells in random locations
	No info